

Table 1. Fractional atomic coordinates and equivalent isotropic displacement parameters (\AA^2)

	x	y	z	U_{eq}
Be	3/4	0.2344 (13)	0	0.026 (4)
I	0.48630 (5)	-0.00410 (3)	0.078806 (11)	0.0144 (3)
O1W	0.7523 (5)	0.3161 (6)	0.03115 (12)	0.0320 (14)
O2W	0.6253 (5)	0.1548 (5)	0.00081 (11)	0.0306 (14)
O3	0.4194 (4)	0.0176 (4)	0.04080 (9)	0.0208 (11)
O4	0.5605 (4)	-0.1519 (4)	0.06973 (10)	0.0221 (11)
O5	0.3457 (4)	-0.0746 (4)	0.09501 (9)	0.0206 (11)
O6	0.6263 (4)	0.0805 (4)	0.06349 (10)	0.0238 (12)
O7	0.4277 (5)	0.1518 (4)	0.09268 (13)	0.0276 (13)
O8	0.5634 (5)	-0.0132 (5)	0.11893 (13)	0.0277 (13)

Table 2. Selected geometric parameters (\AA , $^\circ$)

IO ₆ octahedron				
I—O3	1.799 (4)	I—O6	1.899 (4)	
I—O4	1.844 (4)	I—O7	1.910 (5)	
I—O5	1.850 (4)	I—O8	1.915 (5)	
O3—I—O4	95.9 (2)	O5—I—O7	88.6 (2)	
O3—I—O5	93.3 (2)	O6—I—O7	86.8 (2)	
O4—I—O5	94.6 (2)	O3—I—O8	175.0 (2)	
O3—I—O6	87.1 (2)	O4—I—O8	87.2 (2)	
O4—I—O6	89.9 (2)	O5—I—O8	90.3 (2)	
O5—I—O6	175.4 (2)	O6—I—O8	89.0 (2)	
O3—I—O7	91.6 (2)	O7—I—O8	85.1 (2)	
O4—I—O7	171.7 (2)			
BeO ₄ tetrahedron				
Be—O1W	1.604 (9)	Be—O2W	1.613 (10)	
Be—O1W ⁱⁱⁱ	1.604 (9)	Be—O2W ⁱⁱⁱ	1.613 (10)	
O1W—Be—O1W ⁱⁱⁱ	112.5 (10)	O1W—Be—O2W	107.1 (3)	
O1W—Be—O2W ⁱⁱⁱ	107.6 (2)	O1W ⁱⁱⁱ —Be—O2W	107.7 (2)	
O1W ⁱⁱⁱ —Be—O2W ⁱⁱⁱ	107.1 (3)	O2W ⁱⁱⁱ —Be—O2W	115.0 (9)	
Possible hydrogen bonds [$d(\text{O}\cdots\text{O}) < 3.3 \text{ \AA}]$				
O1W ⁱⁱ —O3 ⁱ	2.638 (7)	O5 ⁱⁱ —O8 ^{ix}	3.157 (7)	
O1W ⁱⁱ —O6	3.226 (8)	O6 ⁱⁱ —O5 ⁱ	2.747 (6)	
O1W ⁱⁱ —O4 ^{vi}	2.648 (6)	O6 ⁱⁱ —O7 ⁱ	3.229 (7)	
O2W ⁱⁱ —O3 ^{iv}	2.636 (6)	O7 ⁱⁱ —O7 ⁱ	2.659 (9)	
O2W ⁱⁱ —O6	2.804 (6)	O7 ⁱⁱ —O8 ^{xii}	2.679 (8)	
O2W ⁱⁱ —O3	3.194 (7)	O8 ⁱⁱ —O8 ^{xii}	2.722 (9)	
O4 ⁱⁱ —O4 ^v	2.513 (9)	O8 ⁱⁱ —O4 ^{vii}	3.276 (7)	
O5 ⁱⁱ —O5 ^{ix}	2.588 (8)			

Symmetry codes: (i) $1-x, \frac{1}{2}-y, z$; (ii) $\frac{3}{2}-x, y-\frac{1}{2}, z$; (iii) $\frac{3}{2}-x, y, -z$; (iv) $1-x, -y, -z$; (v) $1-x, -\frac{1}{2}-y, z$; (vi) $\frac{3}{2}-x, \frac{1}{2}+y, z$; (vii) $\frac{3}{4}+y, x-\frac{3}{4}, \frac{1}{4}-z$; (viii) $\frac{3}{4}-y, x-\frac{1}{4}, \frac{1}{4}-z$; (ix) $\frac{1}{4}-y, \frac{1}{4}-x, \frac{1}{4}-z$; (x) $x+\frac{1}{2}, -y, z$; (xi) $x-\frac{1}{2}, -y, z$; (xii) $\frac{1}{4}+y, \frac{3}{4}-x, \frac{1}{4}-z$.

Polycrystalline samples of the compound were characterized by X-ray analysis using the Guinier technique with Cu K α radiation and quartz as internal standard. The unit-cell dimensions were calculated by least-squares methods (LSUCR: Least Squares Unit Cell Refinement, Programmabibliothek für die Chemie, HRZ Köln, Germany). The crystal studied was mounted in a sealed glass capillary. The space group was inferred from precession photographs of $hk0$, $hk1$, $hk2$, $0kl$, $1kl$ and $2kl$ layers taken using a Buerger precession camera (Firma Huber, Rimsting) and powder data. The data were corrected for Lorentz and polarization effects. Empirical absorption corrections were applied via ψ scans of nine reflections in the range $3.86 < \theta < 24.72^\circ$. The standard reflections were 10,0,0, 0,10,0, and 0,0,40. The positions of the H atoms were deduced from difference Fourier maps. H atoms were refined with a common isotropic displacement parameter ($U_{\text{iso}} = 0.05 \text{ \AA}^2$).

Data collection: CAD-4 Software (Enraf-Nonius, 1989). Cell refinement: LSUCR. Data reduction: NRCVAX (Gabe, Le Page, Charland, Lee & White, 1989). Program(s) used to

solve structure: NRCVAX. Program(s) used to refine structure: SHELXL93 (Sheldrick, 1993). Molecular graphics: ORTEPII (Johnson, 1976) and SCHAKAL92 (Keller, 1992).

Lists of structure factors, anisotropic displacement parameters, H-atom coordinates and complete geometry have been deposited with the IUCr (Reference: DU1154). Copies may be obtained through The Managing Editor, International Union of Crystallography, 5 Abbey Square, Chester CH1 2HU, England.

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K₂Be₂Si₃O₉, a Potassium Beryllium Silicate Framework Built from Edge-Sharing Be—O Tetrahedra and Three-Ring Silicate Tetrahedra

XIANHUI BU, THURMAN E. GIER AND GALEN D. STUCKY

Chemistry Department, University of California, Santa Barbara, CA 93106, USA. E-mail: xianhui@sbxray.ucsb.edu

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Abstract

Dipotassium diberyllium trisilicon nonaoxide, K₂Be₂Si₃O₉, was synthesized at high temperature and high pressure and has a three-dimensional framework structure containing six-ring channels along the b axis. The framework is built from cyclic trimers of silicate tetrahedra and edge-sharing Be—O tetrahedra.

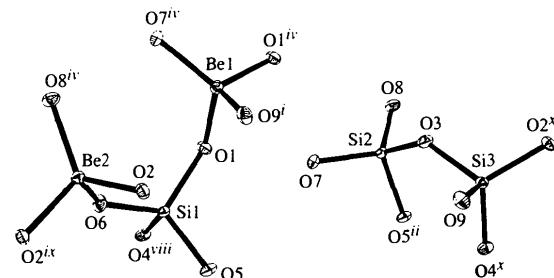
Comment

Zeolite structures based on two types of tetrahedral atoms which have a combined formal charge of +7 or

+8 are well known. These include aluminosilicates (+7), zincophosphates (+7) and aluminophosphates (+8). In comparison, there are relatively few zeolite structures based on tetrahedral atoms which have a combined formal charge of +6. The beryllio-silicate lovdarite is one of the zeolite minerals. It is hydrated and contains both Na^+ and K^+ cations (Merlino, 1981).

In the course of research focused on the preparation of beryllio-silicates, several high temperature and high pressure syntheses were carried out. In one of these, a new potassium beryllium silicate was synthesized, the structure of which is reported here.

The structure contains three unique Si^{4+} ions and two unique Be^{2+} ions (Fig. 1). The framework is built from cyclic silicate trimers and edge-sharing $\text{Be}-\text{O}$ tetrahedra. Since the edge-sharing $\text{Be}-\text{O}$ tetrahedra are located near the inversion centers at $(0,0,0)$ and $(1/2,1/2,1/2)$, each group consists of only one crystallographically unique Be cation and there are, therefore, two crystallographically independent $\text{Be}-\text{O}$ clusters. However, there is only one unique three-ring Si_3O_9 unit.



slowly cooled to about 523 K over a period of 30 h and then to about 373 K for another 40 h. Further cooling to ambient conditions and recovery *via* standard filtration and washing techniques yielded 20 mg of small crystals suitable for the structure determination.

Crystal data



*M*_r = 324.49

Monoclinic

*P*2₁/c

a = 10.259 (6) Å

b = 6.940 (4) Å

c = 12.175 (7) Å

β = 106.764 (7) $^\circ$

V = 830.0 (8) Å³

Z = 4

*D*_x = 2.597 Mg m⁻³

*D*_n not measured

Mo *K* α radiation

λ = 0.7107 Å

Cell parameters from 18 reflections

θ = 20–22.5 $^\circ$

μ = 1.605 mm⁻¹

T = 293 (2) K

Translucent plate

0.17 × 0.17 × 0.067 mm

Clear

Data collection

Huber four-circle diffractometer

0/2θ scans

Absorption correction:

ψ scan (North, Phillips & Mathews, 1968)

*T*_{min} = 0.678, *T*_{max} = 0.862

4926 measured reflections

2390 independent reflections

2201 observed reflections [*I* > 2σ(*I*)]

*R*_{int} = 0.0641

$\theta_{\text{max}} = 29.93^\circ$

h = 0 → 14

k = -9 → 9

l = -17 → 16

3 standard reflections monitored every 97

reflections

intensity decay: none

Refinement

Refinement on *F*²

R[*F*² > 2σ(*F*²)] = 0.0329

wR(*F*²) = 0.0990

S = 1.206

2390 reflections

145 parameters

w = 1/[σ²(*F*_o²) + (0.0189*P*)² + 1.1430*P*]

where *P* = (*F*_o² + 2*F*_c²)/3

(Δ/σ)_{max} = -0.003

Δρ_{max} = 0.568 e Å⁻³

Δρ_{min} = -0.768 e Å⁻³

Extinction correction: none

Atomic scattering factors from *International Tables for Crystallography* (1992, Vol. C, Tables 4.2.6.8 and 6.1.1.4)

Table 1. Fractional atomic coordinates and equivalent isotropic displacement parameters (Å²)

$$U_{\text{eq}} = (1/3)\sum_i \sum_j U_{ij} a_i^* a_j^* \mathbf{a}_i \cdot \mathbf{a}_j$$

	<i>x</i>	<i>y</i>	<i>z</i>	<i>U</i> _{eq}
K1	0.45980 (5)	0.12625 (8)	0.64407 (4)	0.01702 (13)
K2	0.06300 (6)	0.60686 (9)	0.14762 (5)	0.02012 (14)
Be1	0.4288 (3)	0.5907 (4)	0.5422 (2)	0.0079 (5)
Be2	0.0650 (3)	0.5723 (4)	0.4424 (2)	0.0076 (5)
Si1	0.25741 (6)	0.31784 (9)	0.37323 (5)	0.00687 (13)
Si2	0.76207 (6)	0.11422 (8)	0.58064 (5)	0.00758 (13)
Si3	0.75823 (5)	-0.03130 (9)	0.81819 (5)	0.00707 (13)
O1	0.40109 (15)	0.4254 (3)	0.43324 (14)	0.0099 (3)
O2	0.10150 (15)	0.4809 (2)	0.57826 (14)	0.0092 (3)
O3	0.7646 (2)	0.1263 (2)	0.71782 (14)	0.0115 (3)
O4	0.2579 (2)	0.2544 (2)	0.74358 (13)	0.0100 (3)
O5	0.2406 (2)	0.1216 (2)	0.44478 (14)	0.0103 (3)
O6	0.1276 (2)	0.4505 (2)	0.35968 (14)	0.0108 (3)
O7	0.6224 (2)	0.1988 (2)	0.50017 (15)	0.0120 (3)
O8	0.8991 (2)	0.2022 (2)	0.56074 (15)	0.0112 (3)
O9	0.6239 (2)	0.0067 (3)	0.85612 (14)	0.0113 (3)

Table 2. Selected geometric parameters (Å, °)

K1—O9	2.771 (2)	Be1—O1 ⁱⁱ	1.687 (3)
K1—O9 ^{iv}	2.776 (2)	Be1—O1	1.715 (3)
K1—O7	2.791 (2)	Be2—O6	1.585 (3)
K1—O5	2.792 (2)	Be2—O8 ⁱⁱ	1.611 (3)
K1—O4	2.828 (2)	Be2—O2 ^{ix}	1.694 (3)
K1—O7 ⁱⁱ	2.834 (2)	Be2—O2	1.709 (3)
K1—O3	2.994 (2)	Si1—O6	1.588 (2)
K1—O1	3.220 (2)	Si1—O1	1.625 (2)
K2—O6	2.701 (2)	Si1—O5	1.652 (2)
K2—O8 ⁱⁱ	2.742 (2)	Si1—O4 ^{viii}	1.658 (2)
K2—O3 ^{iv}	2.751 (2)	Si2—O7	1.596 (2)
K2—O8 ⁱⁱ	2.756 (2)	Si2—O8	1.614 (2)
K2—O5 ^{xi}	2.993 (2)	Si2—O5 ⁱⁱ	1.665 (2)
K2—O2 ^{vii}	3.041 (2)	Si2—O3	1.665 (2)
K2—O6 ^{xi}	3.069 (2)	Si3—O9	1.596 (2)
K2—O4 ^{xiii}	3.209 (2)	Si3—O2 ^x	1.619 (2)
Be1—O7 ⁱⁱ	1.587 (3)	Si3—O4 ^x	1.653 (2)
Be1—O9 ⁱⁱ	1.597 (3)	Si3—O3	1.655 (2)
O7 ⁱⁱ —Be1—O9 ⁱⁱ	115.7 (2)	O8—Si2—O3	111.69 (9)
O7 ⁱⁱ —Be1—O1 ⁱⁱ	110.3 (2)	O5 ⁱⁱ —Si2—O3	103.35 (9)
O9 ⁱⁱ —Be1—O1 ⁱⁱ	113.8 (2)	O9—Si3—O2 ^x	114.43 (10)
O7 ⁱⁱ —Be1—O1	113.5 (2)	O9—Si3—O4 ^x	107.38 (9)
O9 ⁱⁱ —Be1—O1	109.7 (2)	O2 ^x —Si3—O4 ^x	110.56 (9)
O1 ⁱⁱ —Be1—O1	91.44 (15)	O9—Si3—O3	108.98 (9)
O6—Be2—O8 ⁱⁱ	111.5 (2)	O2 ^x —Si3—O3	108.97 (9)
O6—Be2—O2 ^{ix}	111.4 (2)	O4 ^x —Si3—O3	106.19 (10)
O8 ⁱⁱ —Be2—O2 ^{ix}	115.8 (2)	Si1—O1—Be1 ⁱⁱ	143.79 (15)
O6—Be2—O2	113.6 (2)	Si1—O1—Be1	125.56 (13)
O8 ⁱⁱ —Be2—O2	113.3 (2)	Be1 ⁱⁱ —O1—Be1	88.56 (15)
O2 ^{ix} —Be2—O2	89.59 (15)	Si3 ⁱⁱ —O2—Be2 ^{ix}	137.38 (14)
O6—Si1—O1	113.91 (10)	Si3 ⁱⁱ —O2—Be2	132.12 (13)
O6—Si1—O5	108.69 (9)	Be2 ^{ix} —O2—Be2	90.41 (15)
O1—Si1—O5	111.13 (9)	Si3—O3—Si2	135.61 (11)
O6—Si1—O4 ^{xiii}	108.00 (9)	Si3 ⁱⁱ —O4—Si1 ^{xi}	132.67 (11)
O1—Si1—O4 ^{xiii}	108.39 (9)	Si1 ^{xi} —O5—Si2 ⁱⁱ	135.31 (11)
O5—Si1—O4 ^{xiii}	106.40 (9)	Be2—O6—Si1	136.41 (14)
O7—Si2—O8	115.81 (10)	Be1 ⁱⁱ —O7—Si2	133.81 (15)
O7—Si2—O5 ⁱⁱ	106.49 (9)	Be2 ^{ix} —O8—Si2	125.89 (14)
O8—Si2—O5 ⁱⁱ	108.21 (9)	Si3—O9—Be1 ⁱⁱ	142.94 (14)
O7—Si2—O3	110.39 (10)		

Symmetry codes: (i) 1 - *x*, $\frac{1}{2}$ + *y*, $\frac{3}{2}$ - *z*; (ii) 1 - *x*, -*y*, 1 - *z*; (iii) *x* - 1, $\frac{1}{2}$ - *y*, $\frac{1}{2}$ - *z*; (iv) 1 - *x*, 1 - *y*, 1 - *z*; (v) 1 - *x*, $\frac{1}{2}$ + *y*, $\frac{1}{2}$ - *z*; (vi) -*x*, $\frac{1}{2}$ + *y*, $\frac{1}{2}$ - *z*; (vii) *x*, $\frac{3}{2}$ - *y*, $\frac{1}{2}$ - *z*; (viii) *x*, $\frac{1}{2}$ - *y*, $\frac{1}{2}$ - *z*; (ix) -*x*, 1 - *y*, 1 - *z*; (x) 1 - *x*, *y* - $\frac{1}{2}$, $\frac{3}{2}$ - *z*; (xi) *x*, $\frac{1}{2}$ - *y*, $\frac{1}{2}$ + *z*.

Data collection: *UCLA-CCP* (Strouse, 1991). Cell refinement: *UCLA-CCP*. Data reduction: *UCLA-CCP*. Program(s) used to solve structure: *SHELXS86* (Sheldrick, 1990). Program(s) used to refine structure: *SHELXL93* (Sheldrick, 1993). Molecular graphics: *ATOMS* (Dowty, 1994). Software used to prepare material for publication: *SHELXL93*.

Lists of structure factors, anisotropic displacement parameters and complete geometry have been deposited with the IUCr (Reference: BR1147). Copies may be obtained through The Managing Editor, International Union of Crystallography, 5 Abbey Square, Chester CH1 2HU, England.

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